Notice of References Cited Application/Control No. 10/772,315 Examiner Maria Veronica D. Ewald Applicant(s)/Patent Under Reexamination YOON ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,419,476	07-2002	Ouellette, Joseph P.	425/567
*	В	US-6,179,605	01-2001	Littleton et al.	425/547
*	С	US-4,225,109	09-1980	Yotsutsuji et al.	249/111
*	D	US-4,201,742	05-1980	Hendry, James W.	264/45.5
	Е	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	J	US-			
	κ	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R.					
	s				•	
	Τ·					

NON-PATENT DOCUMENTS

*	<u> </u>	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.